

$V_{RRM} = 6000 \text{ V}$   
 $I_{FAVM} = 1100 \text{ A}$   
 $I_{FSM} = 18 \text{ kA}$   
 $V_{F0} = 1.5 \text{ V}$   
 $r_F = 0.6 \text{ m}\Omega$   
 $V_{DClink} = 3800 \text{ V}$

# Fast Recovery Diode

## 5SDF 10H6004

Doc. No. 5SYA1109-02 Sep. 01

- Patented free-floating silicon technology
- Low on-state and switching losses
- Optimized for use as freewheeling diode in high-voltage GTO converters
- Standard press-pack housing, hermetically plasma-welded
- Cosmic radiation withstand rating

### Blocking

$V_{RRM}$	Repetitive peak reverse voltage	6000 V	Half sine wave, $t_p = 10 \text{ ms}$ , $f = 50 \text{ Hz}$	
$I_{RRM}$	Repetitive peak reverse current	$\leq 50 \text{ mA}$	$V_R = V_{RRM}$ , $T_J = 125^\circ\text{C}$	
$V_{DClink}$	Permanent DC voltage for 100 FIT failure rate	3800 V	100% Duty	Ambient cosmic radiation at sea level in open air.
$V_{DClink}$	Permanent DC voltage for 100 FIT failure rate	V	5% Duty	

### Mechanical data (see Fig. 7)

$F_m$	Mounting force	min.	36 kN	
		max.	44 kN	
a	Acceleration: Device unclamped Device clamped		50 m/s <sup>2</sup> 200 m/s <sup>2</sup>	
m	Weight		0.83 kg	
$D_s$	Surface creepage distance	$\geq$	30 mm	
$D_a$	Air strike distance	$\geq$	20 mm	

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On-state (see Fig. 2, 3)

$I_{FAVM}$	Max. average on-state current	1100 A	Half sine wave, $T_c = 85^\circ\text{C}$	
$I_{FRMS}$	Max. RMS on-state current	1700 A		
$I_{FSM}$	Max. peak non-repetitive surge current	18 kA	$t_p = 10\text{ ms}$	Before surge: $T_c = T_j = 125^\circ\text{C}$
		44 kA	$t_p = 1\text{ ms}$	
$\int I^2 dt$	Max. surge current integral	$1.62 \cdot 10^6\text{ A}^2\text{s}$	$t_p = 10\text{ ms}$	After surge: $V_R \approx 0\text{ V}$
		$0.97 \cdot 10^6\text{ A}^2\text{s}$	$t_p = 1\text{ ms}$	
$V_F$	Forward voltage drop	$\leq 3\text{ V}$	$I_F = 2500\text{ A}$	$T_j = 125^\circ\text{C}$
$V_{F0}$	Threshold voltage	1.5 V	Approximation for	
$r_F$	Slope resistance	0.6 m $\Omega$	$I_F = 200 \dots 6000\text{ A}$	

Turn-on (see Fig. 4, 5)

$V_{fr}$	Peak forward recovery voltage	$\leq 95\text{ V}$	$di/dt = 500\text{ A}/\mu\text{s}$ , $T_j = 125^\circ\text{C}$
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Turn-off (see Fig. 6)

$I_{rr}$	Reverse recovery current	$\leq 1000\text{ A}$	$di/dt = 300\text{ A}/\mu\text{s}$ , $I_F = 3000\text{ A}$ , $T_j = 125^\circ\text{C}$ , $V_{RM} = 6000\text{ V}$ , $C_S = 3\mu\text{F}$ (GTO snubber circuit)
$Q_{rr}$	Reverse recovery charge	$\leq 4700\text{ }\mu\text{C}$	
$E_{rr}$	Turn-off energy	$\leq 3.5\text{ J}$	

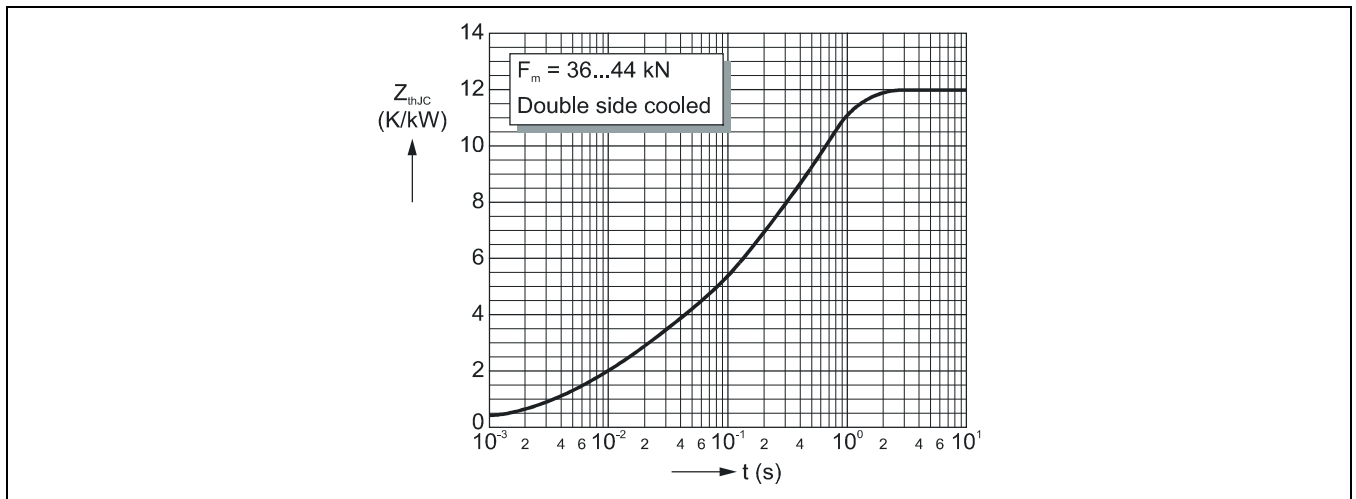
Thermal (see Fig. 1)

$T_j$	Operating junction temperature range	-40...125 $^\circ\text{C}$		
$T_{stg}$	Storage temperature range	-40...125 $^\circ\text{C}$		
$R_{thJC}$	Thermal resistance junction to case	$\leq 24\text{ K/W}$	Anode side cooled	$F_m = 36 \dots 44\text{ kN}$
		$\leq 24\text{ K/W}$	Cathode side cooled	
		$\leq 12\text{ K/W}$	Double side cooled	
$R_{thCH}$	Thermal resistance case to heatsink	$\leq 6\text{ K/W}$	Single side cooled	
		$\leq 3\text{ K/W}$	Double side cooled	

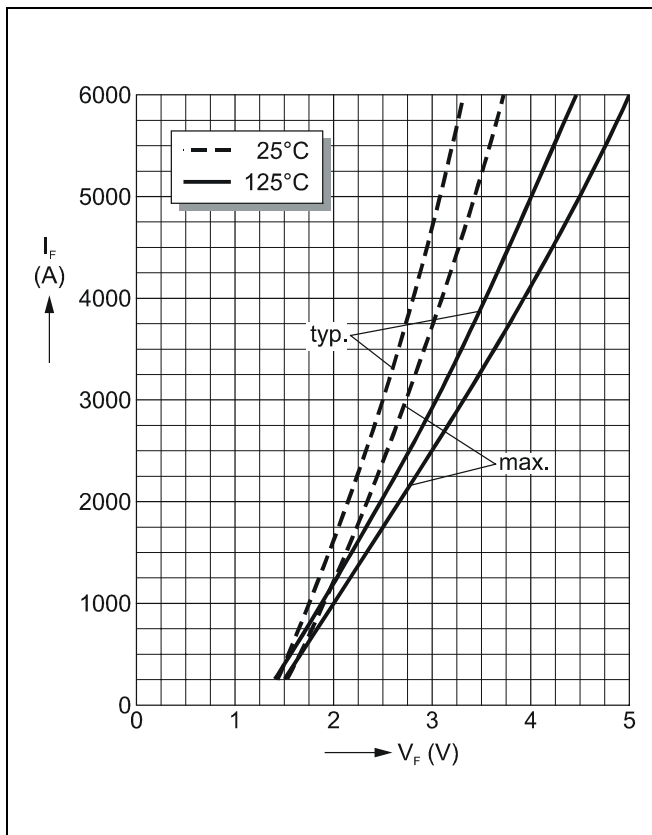
Analytical function for transient thermal impedance.

$$Z_{thJC}(t) = \sum_{i=1}^n R_i (1 - e^{-t/\tau_i})$$

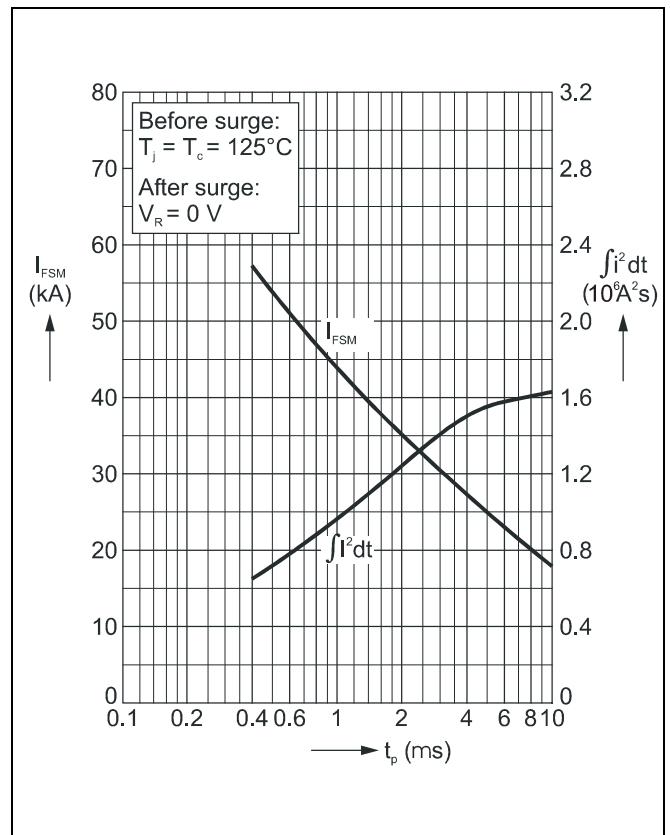
i	1	2	3	4
$R_i(\text{K/W})$	11.83	2.00	1.84	0.71
$\tau_i(\text{s})$	0.47	0.091	0.01	0.0047
$F_m = 36 \dots 44\text{ kN}$ Double side cooled				



**Fig. 1** Transient thermal impedance (junction-to-case) vs. time in analytical and graphical form (max. values).



**Fig. 2** Forward current vs. forward voltage (typ. and max. values) and linear approximation of max. curve at 125°C.



**Fig. 3** Surge current and fusing integral vs. pulse width (max. values) for non-repetitive, half-sinusoidal surge current pulses.

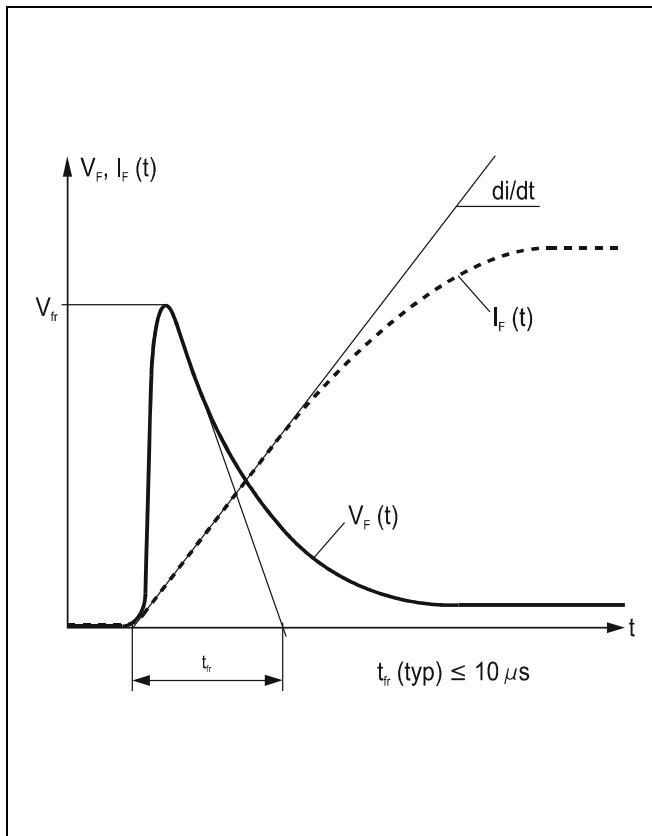


Fig. 4 Typical forward voltage waveform when the diode is turned on with a high  $di/dt$ .

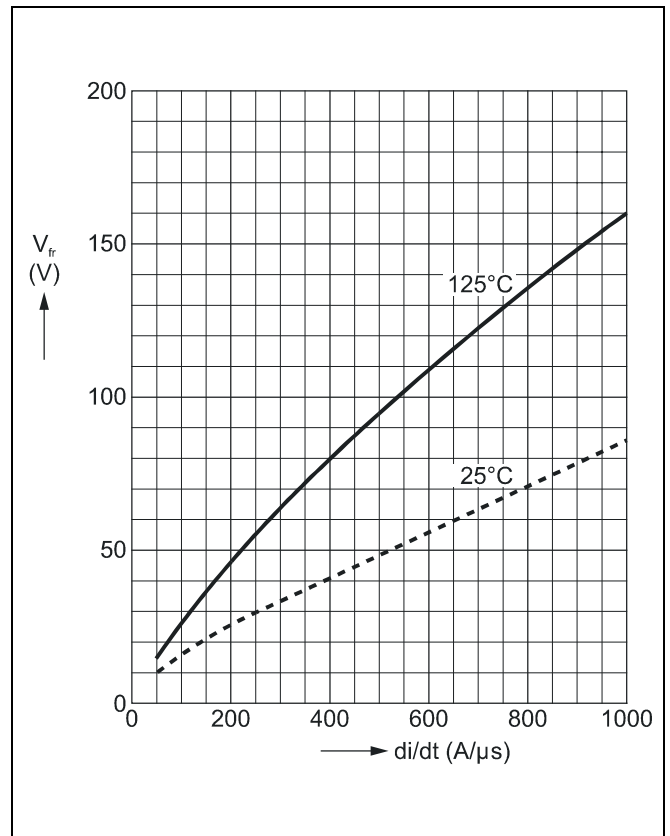


Fig. 5 Forward recovery voltage vs. turn-on  $di/dt$  (max. values).

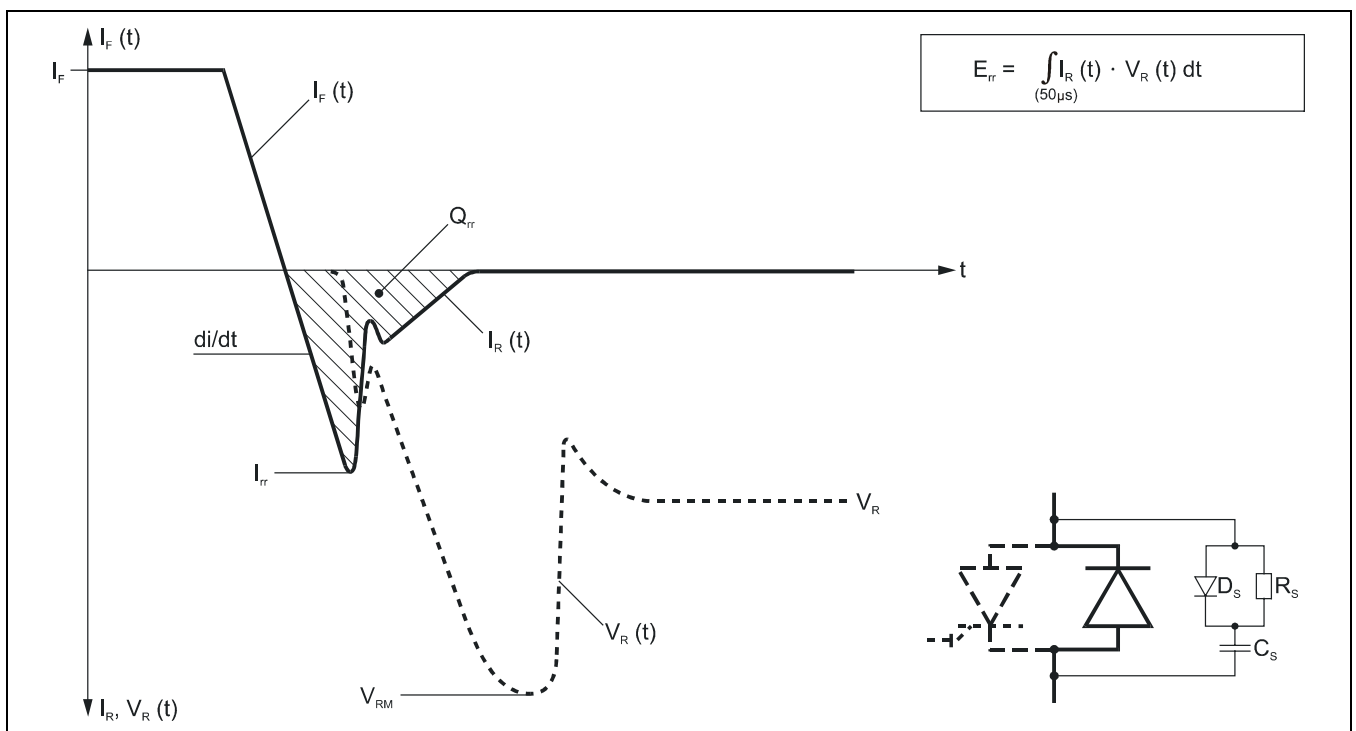
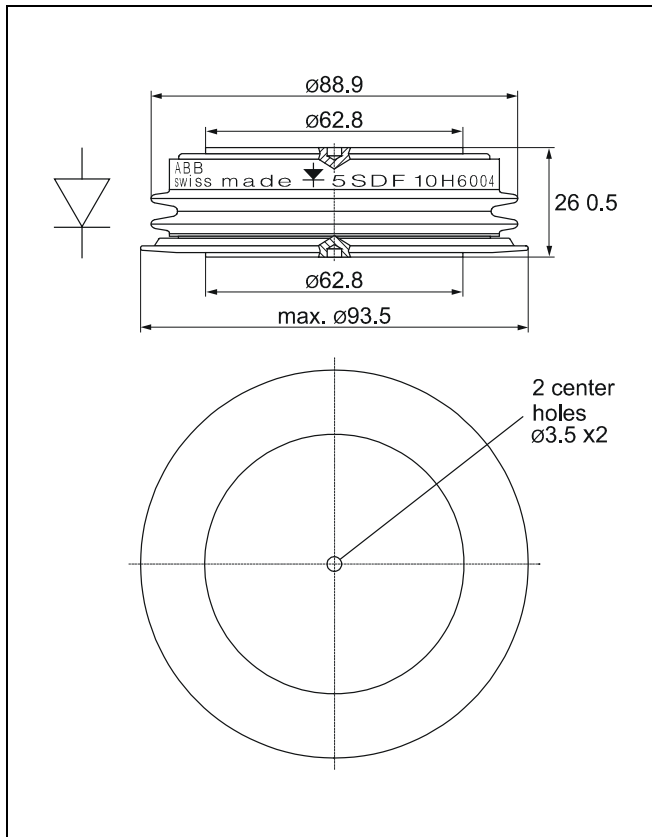


Fig. 6 Typical current and voltage waveforms at turn-off when the diode is connected to an RCD snubber, as often used in GTO circuits.



**Fig. 7 Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.**

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Doc. No. 5SYA1109-02 Sep. 01

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